

September 2014

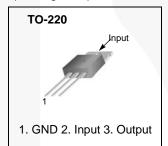
KA79XX / KA79XXA / LM79XX 3-Terminal 1 A Negative Voltage Regulator

Features

- Output Current in Excess of 1 A
- Output Voltages of: -5 V, -6 V, -8 V, -9 V, -12 V, -15 V, -18 V, -24 V
- Internal Thermal Overload Protection
- · Short-Circuit Protection
- Output Transistor Safe Operating Area Compensation

Description

The KA79XX / KA79XXA / LM79XX series of three-terminal negative regulators are available in a TO-220 package with several fixed output voltages, making them useful in a wide range of applications. Each type employs internal current limiting, thermal shutdown, and safe operating area protection.



Ordering Information

Product Number	Output Voltage Tolerance	Package	Packing Method	Operating Temperature			
KA7905TU							
KA7906TU							
KA7908TU							
KA7909TU	±4%						
KA7912TU	± 4 /0	TO-220					
KA7915TU		(Dual Gauge)	Rail				
KA7918TU							
KA7924TU							
KA7912ATU	±2%			0 to +125°C			
KA7915ATU	±2 /0						
LM7905CT							
LM7908CT							
LM7909CT		TO 000					
LM7910CT	±4%	TO-220 (Single Gauge)					
LM7912CT		(Cg.o Gaago)					
LM7915CT							
LM7918CT							

Block Diagram

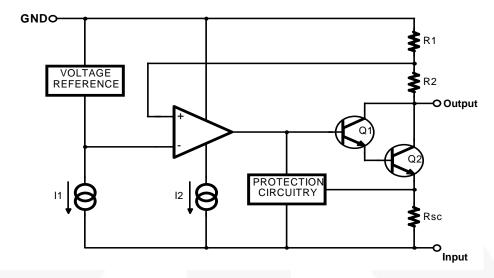


Figure 1. Block Diagram

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. Values are at $T_A = 25^{\circ}\text{C}$ unless otherwise noted.

Symbol	Parameter	Value	Unit
V _I	Input Voltage	-35	V
$R_{\theta JC}$	Thermal Resistance, Junction-Case ⁽¹⁾	5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-Air ^(1, 2)	65	°C/W
T _{OPR}	Operating Temperature Range	0 to +125	°C
T _{STG}	Storage Temperature Range	- 65 to +150	°C

Notes:

- 1. Thermal resistance test board, size: 76.2 mm x 114.3 mm x 1.6 mm(1S0P), JEDEC standard: JESD51-3, JESD51-7.
- 2. Assume no ambient airflow.

Electrical Characteristics (KA7905 / LM7905)

(V_I = -10 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
		T _J = +25°C	-4.80	-5.00	-5.20	
Vo	Output Voltage	I_O = 5 mA to 1 A, $P_O \le 15$ V V_I = -7 V to -20 V	W, -4.75	-5.00	-5.25	V
ΔV_{O}	Line Regulation ⁽³⁾	$T_{.1} = +25^{\circ}C$ $V_{1} = -7$	/ to -25 V	35	100	mV
7,0	Line Regulation	$V_1 = -8$	/ to -12 V	8	50	1110
ΔV_{O}	Load Regulation ⁽³⁾	$T_J = +25^{\circ}C$, $I_O = 5$ mA to 1	1.5 A	10	100	mV
700	Load Regulation	$T_J = +25^{\circ}C$, $I_O = 250$ mA t	o 750 mA	3	50	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$		3	6	mA
Al	Quiescent Current	$I_O = 5$ mA to 1 A		0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -8 \text{ V to } -25 \text{ V}$		0.10	0.80	ША
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA		-0.4		mV/°C
V_N	Output Noise Voltage	$f = 10 Hz$ to 100 kHz, $T_A =$: +25°C	40		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_I = 10 \text{ V}$	54	60		dB
V _D	Dropout Voltage	$T_J = +25^{\circ}C, I_O = 1 A$	_ \	2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I = -35 V$		300		mA
I _{PK}	Peak Current	$T_J = +25^{\circ}C$		2.2		Α

Note:

3. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7906)

(V_I = -11 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	Coi	nditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-5.75	-6.00	-6.25	
V _O	Output Voltage	$I_O = 5 \text{ mA to } 1 \text{ A}$ $V_I = -9 \text{ V to } -21 \text{ V}$		-5.70	-6.00	-6.30	V
$\Delta V_{\mathbf{O}}$	Line Regulation ⁽⁴⁾	T _{.I} = +25°C	$V_{I} = -8 \text{ V to } -25 \text{ V}$		10	120	mV
700	Line regulation	11 = +25 0	$V_{I} = -9 \text{ V to } -13 \text{ V}$		5	60	IIIV
۸۷/ -	Load Regulation ⁽⁴⁾	$T_J = +25^{\circ}C, I_O =$	5 mA to 1.5 A		10	120	mV
ΔV _O	Load Negulation	$T_J = +25^{\circ}C$, $I_O = 250$ mA to 750 mA			3	60	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$	$T_J = +25$ °C		3	6	mA
Al-	Quiescent Current	$I_{O} = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -8 \text{ V to } -25 \text{ V}$	V		0.10	1.30	111/4
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-0.5		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 100	kHz, $T_A = +25^{\circ}C$		130		μV
RR	Ripple Rejection	f = 120 Hz, ΔV _I =	= 10 V	54	60		dB
V_{D}	Dropout Voltage	$T_J = +25^{\circ}C, I_O =$: 1 A		2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$:-35 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		А

Note:

4. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7908 / LM7908)

(V_I = -14 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O =1 μ F; unless otherwise specified.)

Symbol	Parameter	Coi	nditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-7.7	-8.0	-8.3	V
V _O	Output Voltage	$I_O = 5 \text{ mA to } 1 \text{ A}$ $V_I = -10 \text{ V to } -23 \text{ m}$		-7.6	-8.0	-8.4	
ΔV _O	Line Regulation ⁽⁵⁾	T _{.1} = +25°C	$V_I = -10.5 \text{ V to } -25 \text{ V}$		10	160	mV
740	Line Regulation	1j= +25 C	$V_I = -11 \text{ V to } -17 \text{ V}$		5	80	IIIV
ΔV _O	Load Regulation ⁽⁵⁾	$T_J = +25^{\circ}C, I_O =$	= $+25$ °C, I _O = 5 mA to 1.5 A		12	160	mV
700	Load Regulation	$T_J = +25^{\circ}\text{C}, I_O = 250 \text{ mA to } 750 \text{ mA}$			4	80	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA
Al -	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -10.5 \text{ V to } -2.00 \text{ V}$	25 V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _D	$I_O = 5 \text{ mA}$			-0.6		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 100	kHz, $T_A = +25^{\circ}C$		175		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_1 =$	= 10 V	54	60		dB
V _D	Dropout Voltage	$T_J = +25^{\circ}C, I_O =$: 1 A		2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$: -35 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		Α

Note:

5. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7909 / LM7909)

(V_I = -15 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O =1 μ F; unless otherwise specified.)

Symbol	Parameter	Conditions		Min.	Тур.	Max.	Unit	
		$T_J = +25^{\circ}C$		-8.7	-9.0	-9.3		
V _O	Output Voltage	$I_O = 5 \text{ mA to 1 A}$ $V_I = -1.5 \text{ V to } -23$		-8.6	-9.0	-9.4	V	
ΔV _O	Line Regulation ⁽⁶⁾	T _{.1} = +25°C	$V_I = -11.5 \text{ V to } -26 \text{ V}$		10	180	mV	
740	Line Regulation	11 - +23 0	V _I = -12 V to -18 V		5	90	IIIV	
۸۷/۵	Load Regulation ⁽⁶⁾	$T_J = +25^{\circ}C, I_O =$	$I_J = +25^{\circ}\text{C}, I_O = 5 \text{ mA to } 1.5 \text{ A}$		12	180	mV	
ΔV _O	Load Regulation	$T_J = +25$ °C, $I_O = 250$ mA to 750 mA			4	90	IIIV	
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA	
Al -	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA	
ΔI_{Q}	Change	$V_I = -11.5 \text{ V to } -2$	26 V		0.10	1.00] ""A	
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-0.6		mV/°C	
V_N	Output Noise Voltage	f = 10 Hz to 100	kHz, $T_A = +25^{\circ}C$		175		μV	
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_{I} =$	= 10 V	54	60		dB	
V_{D}	Dropout Voltage	$T_J = +25^{\circ}C, I_O =$	1 A		2		V	
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	-35 V		300		mA	
I _{PK}	Peak Current	$T_J = +25^{\circ}C$			2.2		Α	

Note:

6. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (LM7910)

(V_I = -17 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O =1 μ F; unless otherwise specified.)

Symbol	Parameter	Cor	nditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-9.6	-10.0	-10.4	
V _O	Output Voltage	$I_O = 5 \text{ mA to 1A},$ $V_I = -12 \text{ V to -28}$		-9.5	-10.0	-10.5	V
41/	Line Regulation ⁽⁷⁾	T _{.1} = +25°C	$V_I = -12.5 \text{ V to } -28 \text{ V}$		12	200	mV
ΔV_{O}	Line Regulation 7	1 _J = +25 C	V _I = -14 V to -20 V		6	100	IIIV
41/	Load Regulation ⁽⁷⁾	$T_J = +25^{\circ}C$, $I_O = 5 \text{ mA to } 1.5$	A		12	200	mV
ΔV _O	Load Regulation	$T_J = +25^{\circ}\text{C},$ $I_O = 250 \text{ mA to } 7$	'50 mA		4	100	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$	T _J = +25°C		3	6	mA
A.I.	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_I = -12.5 \text{ V to } -2$	28 V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _O	I _O = 5 mA			-1		mV/°C
V _N	Output Noise Voltage	10 Hz ≤ f ≤ 100 k	(Hz, T _A = +25°C		280		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_I =$	f = 120 Hz, ΔV _I = 10 V		60		dB
V_{D}	Dropout Voltage	T _J = +25°C, I _O = 1 A			2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	$T_J = +25^{\circ}C, V_I = -35 \text{ V}$		300		mA
I _{PK}	Peak Current	$T_J = +25^{\circ}C$			2.2		Α

Note:

7. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7912 / LM7912)

(V_I = -19 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	Co	onditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-11.5	-12.0	-12.5	
V _O	Output Voltage	0	$I_{O} = 5 \text{ mA to 1 A, } P_{O} \le 15 \text{ W}$ $V_{I} = -15.5 \text{ V to -27 V}$		-12.0	-12.6	V
ΔV_{O}	Line Regulation ⁽⁸⁾	T _{.I} = +25°C	$V_I = -14.5 \text{ V to } -30 \text{ V}$		12	240	mV
7,0	Line Regulation	11 = +23 C	$V_1 = -16 \text{ V to } -22 \text{ V}$		6	120	111 V
ΔV_{O}	Load Regulation ⁽⁸⁾	$T_J = +25^{\circ}C, I_O = -25^{\circ}C$	= $+25$ °C, I _O = 5 mA to 1.5 A		12	240	mV
ΔνΟ	Load Regulation	$T_J = +25^{\circ}C, I_O = -25^{\circ}C$	$T_J = +25^{\circ}C$, $I_O = 250$ mA to 750 mA		4	120	1117
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA
Al	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$	A		0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -14.5 \text{ V to} \cdot$	-30 V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA	·		-0.8		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 100	$0 \text{ kHz}, T_A = +25^{\circ}\text{C}$		200		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_{\parallel}$	f = 120 Hz, ΔV _I = 10 V		60		dB
V_{D}	Dropout Voltage	$T_J = +25^{\circ}C, I_O = 1 A$			2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	= -35 V		300		mA
I _{PK}	Peak Current	$T_J = +25^{\circ}C$			2.2		Α

Note:

8. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7915 / LM7915)

(V_I = -23 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	C	onditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-14.40	-15.00	-15.60	
V _O	Output Voltage	$I_O = 5 \text{ mA to 1}$ $V_I = -18 \text{ V to -}$	A, P _O ≤ 15 W 30 V	-14.25	-15.00	-15.75	V
ΔV_{O}	Line Regulation ⁽⁹⁾	T _{.1} = +25°C	$V_I = -17.5 \text{ V to } -30 \text{ V}$		12	300	mV
Δνο	Line Regulation	1j = +25 C	V _I = -20 V to -26 V		6	150	IIIV
ΔV_{O}	Load Regulation ⁽⁹⁾	$T_J = +25^{\circ}C, I_C$) = 5 mA to 1.5 A		12	300	mV
740	Load Regulation	$T_J = +25^{\circ}\text{C}$, $I_O = 250 \text{ mA to } 750 \text{ mA}$			4	150	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA
Al	Quiescent Current	I _O = 5 mA to 1 A			0.05	0.50	mA
ΔI_{Q}	Change	V _I = -17.5 V to	-30 V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA	·		-0.9		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 10	00 kHz, $T_A = +25^{\circ}C$		250		μV
RR	Ripple Rejection	f = 120 Hz, Δ\	f = 120 Hz, ΔV _I = 10 V		60		dB
V _D	Dropout Voltage	$T_J = +25^{\circ}C, I_C$) = 1 A		2		V
I _{SC}	Short-Circuit Current	T _J = +25°C, V	_I = -35 V		300		mA
I _{PK}	Peak Current	$T_J = +25^{\circ}C$			2.2		Α

Note:

9. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7918 / LM7918)

(V_I = -27 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O =1 μ F, unless otherwise specified.)

Symbol	Parameter	Cor	nditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-17.3	-18.0	-18.7	
V _O	Output Voltage	$I_O = 5 \text{ mA to } 1 \text{ A}$ $V_I = -22.5 \text{ V to } -300$		-17.1	-18.0	-18.9	V
ΔV _O	Line Regulation ⁽¹⁰⁾	T _{.1} = +25°C	$V_{I} = -21 \text{ V to } -33 \text{ V}$		15	360	mV
70	Line Regulation	11 = +23 C	$V_1 = -24 \text{ V to } -30 \text{ V}$		8	180	IIIV
۸۱/۵	Load Regulation ⁽¹⁰⁾	$T_J = +25^{\circ}C, I_O =$	= $+25$ °C, I _O = 5 mA to 1.5 A		15	360	mV
700	ΔV _O Load Regulation ⁽¹⁰⁾		T_J = +25°C, I_O = 250 mA to 750 mA		5	180	1117
IQ	Quiescent Current	T _J = +25°C			3	6	mA
Al-	Quiescent Current	$I_O = 5 \text{ mA to 1 A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -21 \text{ V to } -33$	V		0.10	1.00	ША
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-1		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 100	kHz, $T_A = +25^{\circ}C$		300		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_I =$	= 10 V	54	60		dB
V_{D}	Dropout Voltage	$T_J = +25^{\circ}C, I_O =$	1 A		2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	-35 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		А

Note:

10. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7924)

(V_I = -33 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	Cond	itions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-23.0	-24.0	-25.0	
V _O	Output Voltage	$I_O = 5 \text{ mA to 1 A, F}$ $V_I = -27 \text{ V to -38 V}$	•	-22.8	-24.0	-25.2	V
ΔV _O	Line Regulation ⁽¹¹⁾	T _{.1} = +25°C	$V_{I} = -27 \text{ V to } -38 \text{ V}$		15	480	mV
740	Line Regulation	11 = +23 0	$V_{I} = -30 \text{ V to } -36 \text{ V}$		8	180	IIIV
۸۷/۵	Load Regulation ⁽¹¹⁾	$T_J = +25^{\circ}C, I_O = 5$	= $+25^{\circ}$ C, I _O = 5 mA to 1.5 A		15	480	mV
ΔV _O	Load Regulation	$T_J = +25^{\circ}C$, $I_O = 250$ mA to 750 mA			5	240	IIIV
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA
Al -	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_1 = -27 \text{ V to } -38 \text{ V}$			0.10	1.00	ША
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-1		mV/°C
V_N	Output Noise Voltage	f = 10 Hz to 100 kH	Hz, $T_A = +25^{\circ}C$		400		μV
RR	Ripple Rejection	$f = 120 \text{ Hz}, \Delta V_{I} = 1$	0 V	54	60		dB
V _D	Dropout Voltage	$T_J = +25^{\circ}C, I_O = 1$	A		2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I = -3$	85 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		Α

Note:

11. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7912A)

(V_I = -19 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O =1 μ F; unless otherwise specified.)

Symbol	Parameter	Cor	nditions	Min.	Тур.	Max.	Unit
		T _J = +25°C		-11.75	-12.00	-12.25	
Vo	Output Voltage	$I_O = 5 \text{ mA to } 1 \text{ A}$ $V_I = -15.5 \text{ V to } -2$		-11.50	-12.00	-12.50	V
	Line Regulation ⁽¹²⁾	T = 125°C	$V_I = -14.5 \text{ V to } -27 \text{ V},$ $Io = 1 \text{ A}$		12	120	
ΔV _O		T _J = +25°C -	V _I = -16 V to -22 V, lo = 1 A		6	60	mV
		$V_I = -14.8 \text{ V to } -3$	30 V		12	120	
		V _I = -16 V to -22 V, Io = 1 A			12	120	
۸\/	Load Regulation ⁽¹²⁾	$T_J = +25^{\circ}C$, $I_O = 5$ mA to 1.5 A			12	150	mV
ΔV _O	Load Negulation	$T_J = +25$ °C, $I_O = 250$ mA to 750 mA			4	75	111 V
IQ	Quiescent Current	T _J = +25°C	T _J = +25°C		3	6	mA
41	Quiescent Current	$I_O = 5 \text{ mA to } 1 \text{ A}$			0.05	0.50	mA
ΔI_{Q}	Change	$V_{I} = -15 \text{ V to } -30$	V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-0.8		mV/°C
V _N	Output Noise Voltage	f = 10 Hz to 100	kHz, T _A = +25°C		200		μV
RR	Ripple Rejection	f = 120 Hz, ΔV _I =	f = 120 Hz, ΔV _I = 10 V		60		dB
V _D	Dropout Voltage	T _J = +25°C, I _O = 1 A			2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	-35 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		Α

Note:

12. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

Electrical Characteristics (KA7915A)

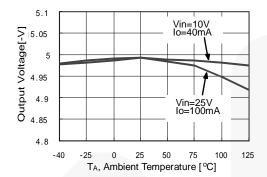
(V_I = -23 V, I_O = 500 mA, 0° C \leq T_J \leq +125 $^{\circ}$ C, C_I = 2.2 μ F, C_O = 1 μ F; unless otherwise specified.)

Symbol	Parameter	Conditions		Min.	Тур.	Max.	Unit
		T _J = +25°C		-14.7	-15.0	-15.3	V
V _O	Output Voltage	$I_O = 5 \text{ mA to 1 A}, P_O \le 15 \text{ W},$ $V_I = -18 \text{ V to } -30 \text{ V}$		-14.4	-15.0	-15.6	
ΔV _O	Line Regulation ⁽¹³⁾	T _J = +25°C	$V_I = -17.5 \text{ V to } -30 \text{ V},$ $Io = 1 \text{ A}$		12	150	mV
			V _I = -20 V to -26 V, lo = 1 A		6	75	
		V _I = -17.9 V to -30 V			12	150	- -
		V _I = -20 V to -26 V, Io = 1 A			6	150	
41/	Load Regulation ⁽¹³⁾	$T_J = +25^{\circ}C$, $I_O = 5$ mA to 1.5 A			12	150	mV
ΔV _O		$T_J = +25^{\circ}C$, $I_O = 250$ mA to 750 mA			4	75	
IQ	Quiescent Current	$T_J = +25^{\circ}C$			3	6	mA
ΔI_Q	Quiescent Current Change	I _O = 5 mA to 1 A			0.05	0.50	mA
		$V_{I} = -18.5 \text{ V to } -3$	30 V		0.10	1.00	IIIA
ΔVο/ΔΤ	Temperature Coefficient of V _D	I _O = 5 mA			-0.9		mV/°C
V _N	Output Noise Voltage	f = 10 Hz to 100 kHz, T _A = +25°C			250		μV
RR	Ripple Rejection	f = 120 Hz, ΔV _I = 10 V		54	60		dB
V _D	Dropout Voltage	$T_J = +25^{\circ}C, I_O =$	1 A		2		V
I _{SC}	Short-Circuit Current	$T_J = +25^{\circ}C, V_I =$	-35 V		300		mA
I _{PK}	Peak Current	T _J = +25°C			2.2		Α

Note:

13. Load and line regulation are specified at constant junction temperature. Changes in V_O due to heating effects must be taken into account separately. Pulse testing with low duty is used.

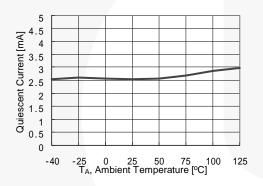
Typical Performance Characteristics



15 13 Io=1.5A Load Regulation[mV] 11 9 7 5 3 1 lo=0.75A -1 -3 -5 0 25 50 75 T_A, Ambient Temperature [°C]

Figure 2. Output Voltage

Figure 3. Load Regulation



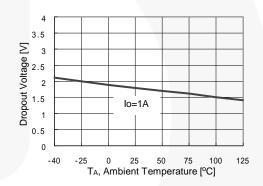


Figure 4. Quiescent Current

Figure 5. Dropout Voltage

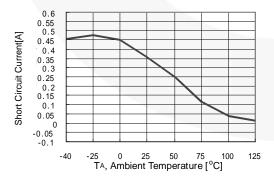


Figure 6. Short-Circuit Current

Typical Applications

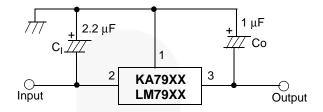


Figure 7. Negative Fixed Output Regulator

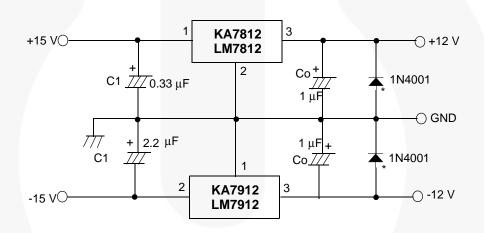
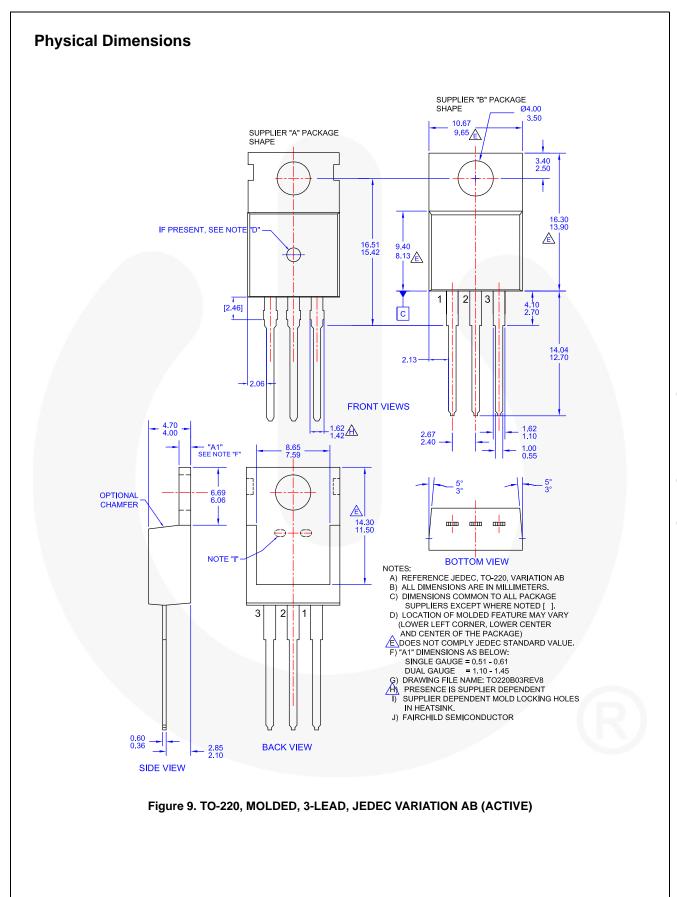


Figure 8. Split Power Supply (±12 V / 1 A)

Notes:

- 14. To specify an output voltage, substitute voltage value for "XX".
- 15. C_I is required if the regulator is located an appreciable distance from the power supply filter. For value given, capacitor must be solid tantalum. If aluminium electronics are used, at least ten times the value shown should be selected.
- 16. C_O improves stability and transient response. If large capacitors are used, a high-current diode from input to output (1N4001 or similar) should be introduced to protect the device from momentary input short circuit.







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